

**Search Notes**

Application/Control No.

10/658,367

Examiner

PHUC H. TRAN

Applicant(s)/Patent under  
Reexamination

LOMNITZ, YUVAL

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner
370	203,204 205,206 207,208 209	2/28/2008	PT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
consulted with Frank Duong; Steven Nguyen	2/15/2008	PT
IEEE search; CiteSeer with Steven Nguyen	2/25/2008	PT
East search see history printout	2/28/2008	PT
Consulted with Khai Tran	1/23/2008	PT